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Applicant(s)/Patent under Reexamination

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EGGEBRAATEN ET AL.

Examiner

Art Unit

Thomas M. Ho

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SEARCHED					
Class	Subclass	Date	Examiner		
380	229	4/2/2006	тн		
705	67, 51, 2	4/2/2006	TH		
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
EAST: US PATENT,EPO, JPO, DERWENT, USPGPUB	4/2/2006	ТН
EAST: US PATENT,EPO, JPO, DERWENT, USPGPUB	4/1/2006	тн
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